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JUN 1 6 2006 Substitute for Form 1449A/PT INFORMATION DISCLOSUR STATEMENT BY APPLICAN

C	Complete If Known					
Application Number	10/565,519					
Filing Date	January 23, 2006					
First Named Inventor	Johannes Benedikt					
Group Art Unit	-Not-Vot-Assigned 2831					
Examiner Name	Not-Net-Assigned					
	Amy He					

(use as many sheets as necessary)

Attorney Docket No. 107687.00019 (ABEL-0007)

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	Exam. Cite Number Kind Code <sup>2</sup> of Applicant of Of Cited D (mm-dd-yy	U.S. Patent Document			Date of Pub.	Pages, Columns, Lines, Where Relevant Passages or Relevant Figure
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/A.H./	AD	10/565,519				A prior art active load pull circuit as shown in Figure 1 of the present application and described on pg. 1, line 30 to pg. 3, line 5 of the present application.
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L	AF					
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Exam. Initials*	Cite No.¹	Foreign Patent Document			Name of Patentee	Date of Pub.	Pages, Columns, Lines, Where Relevant	T
		Office <sup>3</sup>	Number⁴	Kind Code <sup>2</sup> (if known)	of Applicant of Cited Doc.	of Cited Doc. (mm-dd-yyyy)	Passages or Relevant Figures Appear	T⁵
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	BF							
	BG							<b>†</b>
	ВН							İ

		OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS	
Exam. Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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